

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/823,664	AKASAKI ET AL.	
Examiner	Art Unit	
VanThu Nguyen	2824	

	SEARCHED			
Class	Subclass	Date	Examiner	
365	194 o 189.05 189.08 225.7 233	9/29/2005	VTN	
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Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
EAST Search (see print out history)	9/29/2005	VTN